40V N-Ch Power MOSFET

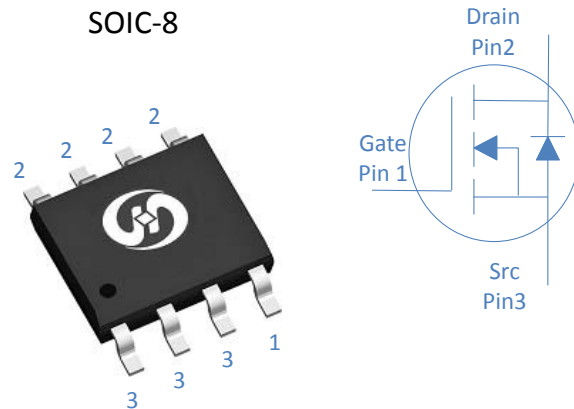| V_{DS}		40	V
$R_{DS(on),typ}$	V_{GS}=10V	9.6	mΩ
$R_{DS(on),typ}$	V_{GS}=4.5V	14.5	mΩ
I_D		12	A

Feature
◇ High Speed Power Switching, logic level
◇ Enhanced Body diode dv/dt capability
◇ Enhanced Avalanche Ruggedness
◇ 100% UIS Tested, 100% Rg Tested
◇ Lead Free

Application
◇ Synchronous Rectification in SMPS
◇ Hard Switching and High Speed Circuit
◇ Power Tools
◇ UPS
◇ Motor Control

Part Number	Package	Marking
HTS130N04	SOIC-8	TS130N04

SOIC-8

Drain Pin2

Gate Pin 1

Src Pin3

Absolute Maximum Ratings at T_j=25℃ (unless otherwise specified)

Parameter	Symbol	Conditions	Value	Unit
Continuous Drain Current (Silicon Limited)	I_D	T_A=25℃	12	A
		T_A=70℃	10	
Drain to Source Voltage	V_{DS}	-	40	V
Gate to Source Voltage	V_{GS}	-	±20	V
Pulsed Drain Current	I_{DM}	-	48	A
Power Dissipation	P_D	T_A=25℃	2.5	W
Operating and Storage Temperature	T_J, T_{stg}	-	-55 to 150	℃

Absolute Maximum Ratings

Parameter	Symbol	Max	Unit
Thermal Resistance Junction-Case	$R_{\theta JC}$	25	℃/W
Thermal Resistance Junction-Ambient	$R_{\theta JA}$	50	℃/W

Electrical Characteristics at T_j=25℃ (unless otherwise specified)

Static Characteristics

Parameter	Symbol	Conditions	Value min	typ	max	Unit
Drain to Source Breakdown Voltage	$V_{(BR)DSS}$	V_{GS}=0V, I_D=250μA	40	-	-	V
Gate Threshold Voltage	$V_{GS(th)}$	V_{GS}=V_{DS}, I_D=250μA	1	1.7	3	
Zero Gate Voltage Drain Current	I_{DSS}	V_{GS}=0V, V_{DS}=32V, T_j=25℃	-	-	1	μA
		V_{GS}=0V, V_{DS}=30V, T_j=125℃	-	-	25	
Gate to Source Leakage Current	I_{GSS}	V_{GS}=±20V, V_{DS}=0V	-	-	±100	nA
Drain to Source on Resistance	$R_{DS(on)}$	V_{GS}=10V, I_D=9A	-	9.6	13	mΩ
		V_{GS}=4.5V, I_D=6A	-	14.5	19	
Transconductance	g_{fs}	V_{DS}=5V, I_D=9A	-	35	-	S

Dynamic Characteristics

Parameter	Symbol	Conditions	min	typ	max	Unit
Input Capacitance	C_{iss}	V_{GS}=0V, V_{DS}=20V, f=1MHz	-	916	-	pF
Output Capacitance	C_{oss}		-	134	-	
Reverse Transfer Capacitance	C_{rss}		-	111	-	
Total Gate Charge (10V)	Q_g(10V)	V_{DD}=20V, I_D=9A, V_{GS}=10V	-	24	-	nC
Gate to Source Charge	Q_{gs}		-	2.6	-	
Gate to Drain (Miller) Charge	Q_{gd}		-	7.5	-	
Turn on Delay Time	$t_{d(on)}$	V_{DD}=20V, I_D=1A, V_{GS}=10V, R_G=6Ω,	-	5	-	ns
Rise time	t_r		-	10	-	
Turn off Delay Time	$t_{d(off)}$		-	15	-	
Fall Time	t_f		-	15	-	

Reverse Diode Characteristics

Parameter	Symbol	Conditions	min	typ	max	Unit
Diode Forward Voltage	V_{SD}	V_{GS}=0V, I_F=9A	-		1.3	V

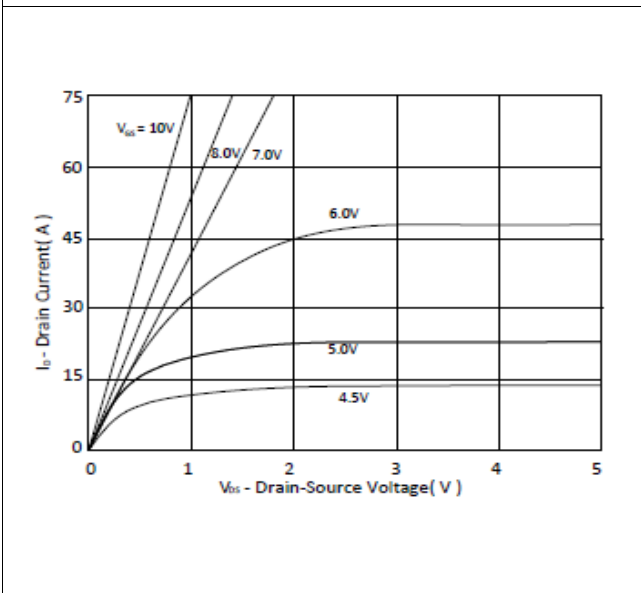| Fig 1. Typical Output Characteristics	Figure 2. On-Resistance vs. Gate-Source Voltage

Fig 1. Typical Output Characteristics
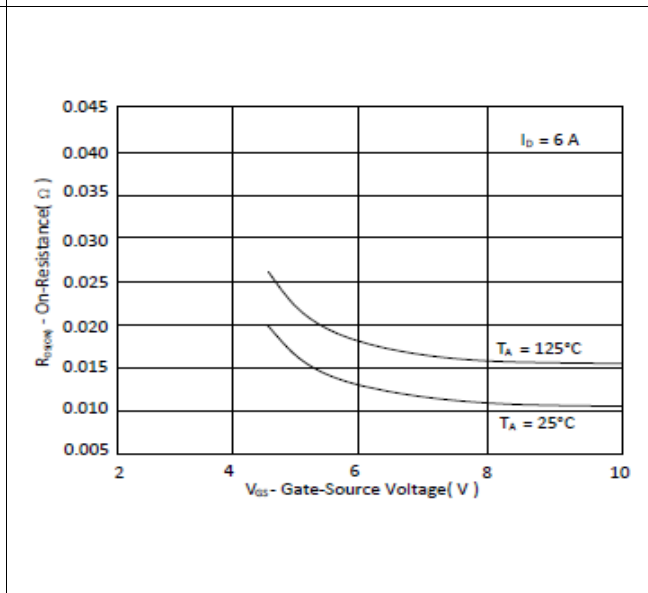

Figure 2. On-Resistance vs. Gate-Source Voltage

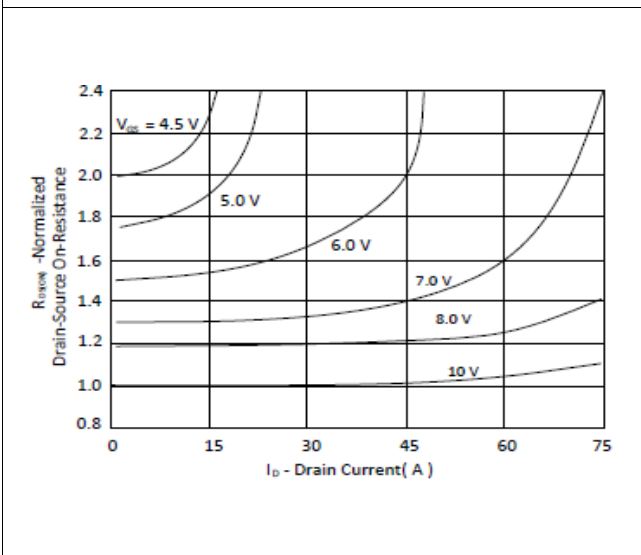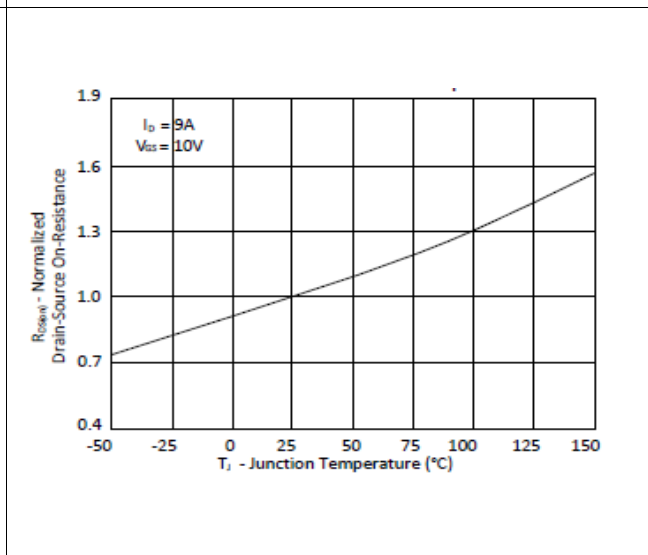| Figure 3. On-Resistance vs. Drain Current and Gate Voltage	Figure 4. Normalized On-Resistance vs. Junction Temperature

Figure 3. On-Resistance vs. Drain Current and Gate Voltage

Figure 4. Normalized On-Resistance vs. Junction Temperature

Figure 5. Typical Transfer Characteristics	Figure 6. Typical Source-Drain Diode Forward Voltage
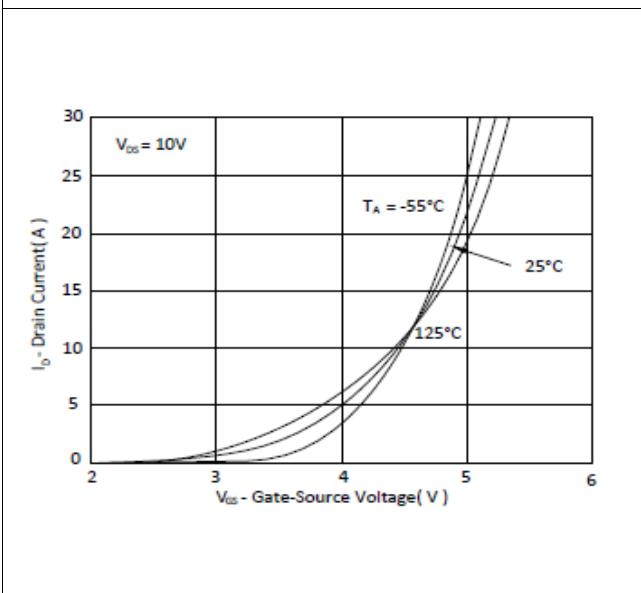
Figure 5. Typical Transfer Characteristics

Figure 6. Typical Source-Drain Diode Forward Voltage

Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage	Figure 8. Typical Capacitance vs. Drain-to-Source Voltage
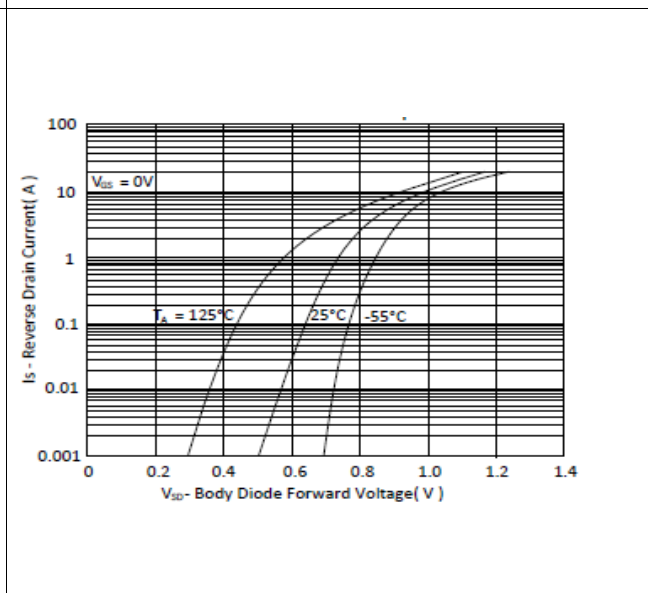
Figure 7. Typical Gate-Charge vs. Gate-to-Source Voltage
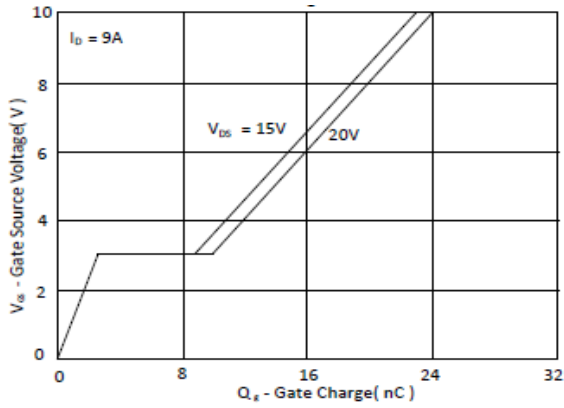
Figure 8. Typical Capacitance vs. Drain-to-Source Voltage
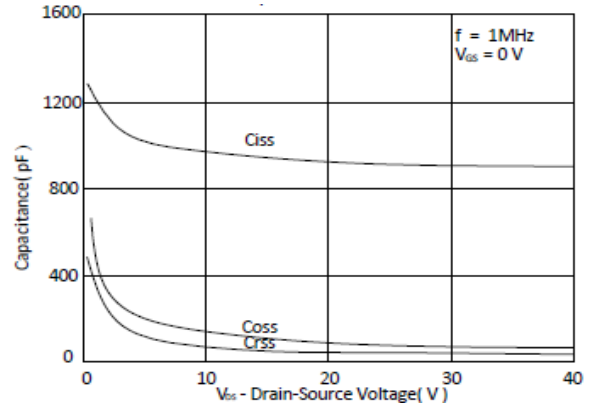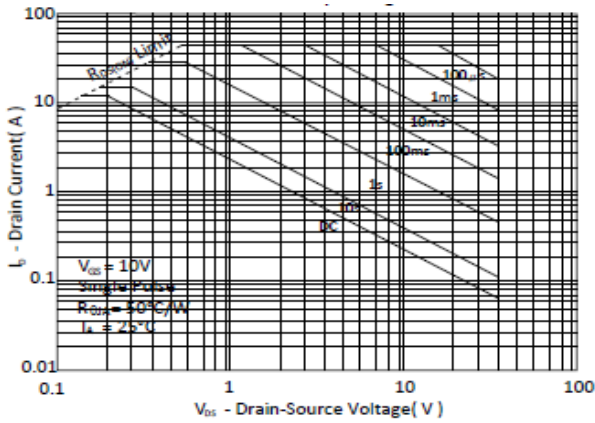
Figure 9. Maximum Safe Operating Area
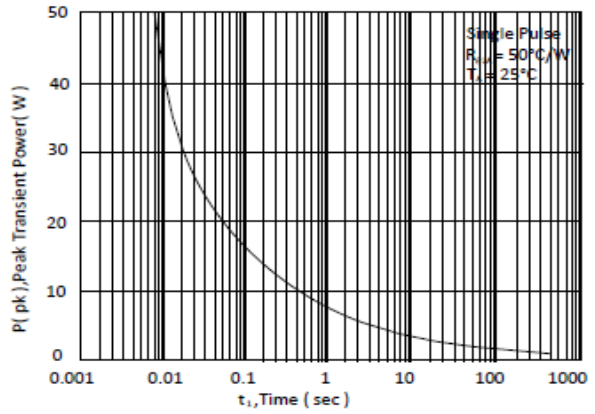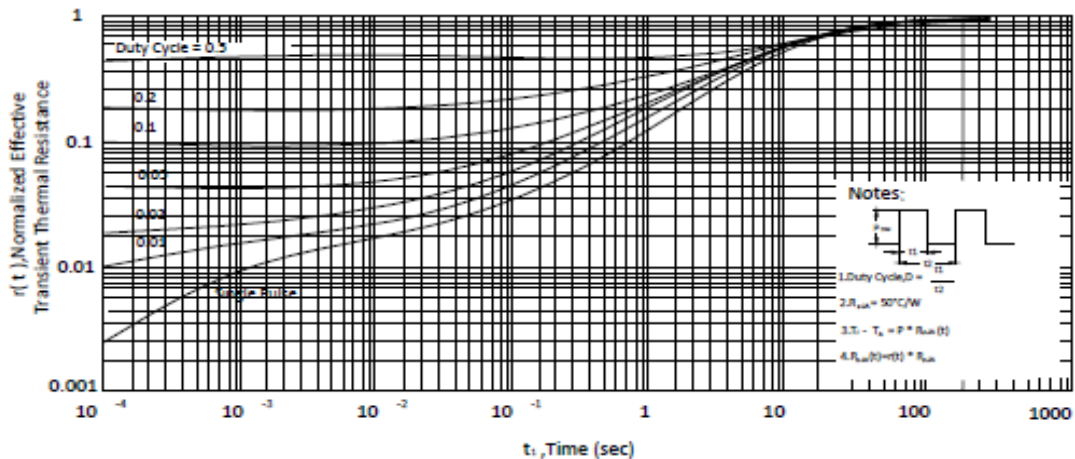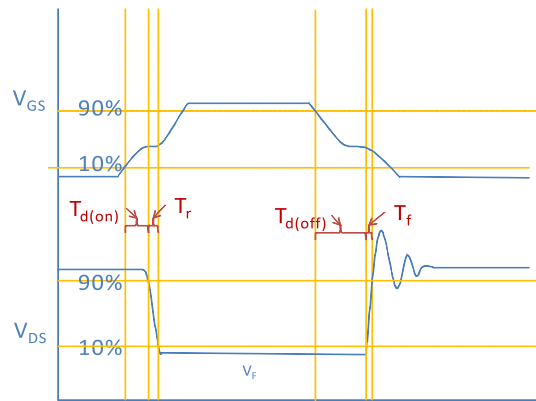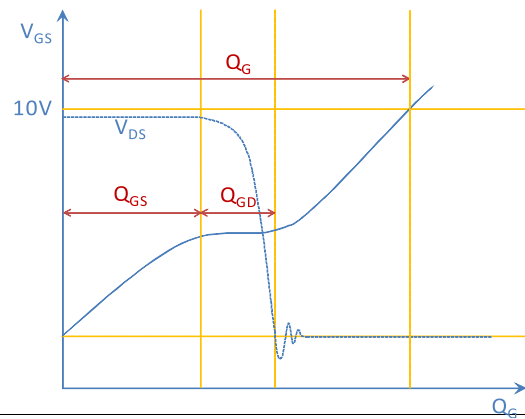
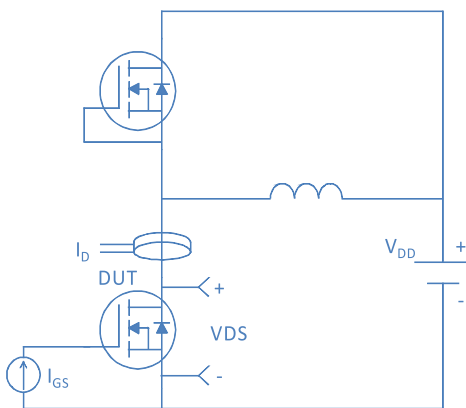Figure 10. Single Pulse Maximum Power Dissipation

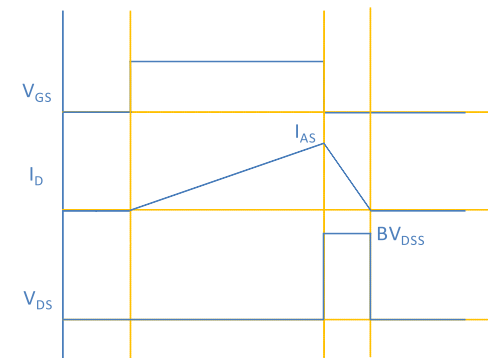Figure 11. Normalized Maximum Transient Thermal Impedance, Junction-to-Case
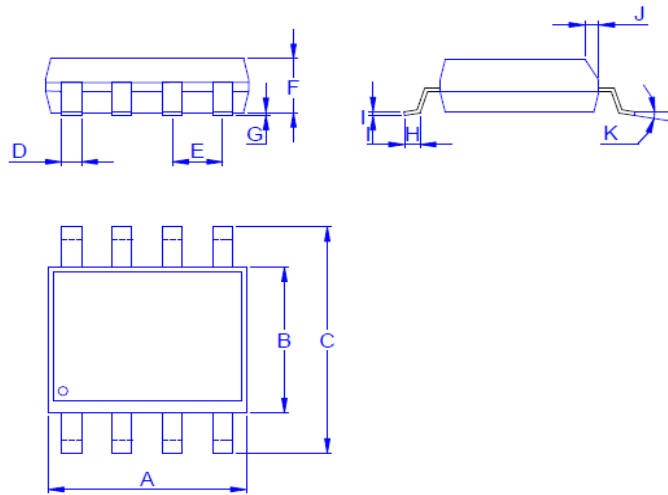
Inductive switching Test

Gate Charge Test

Uclamped Inductive Switching (UIS) Test

Diode Recovery Test
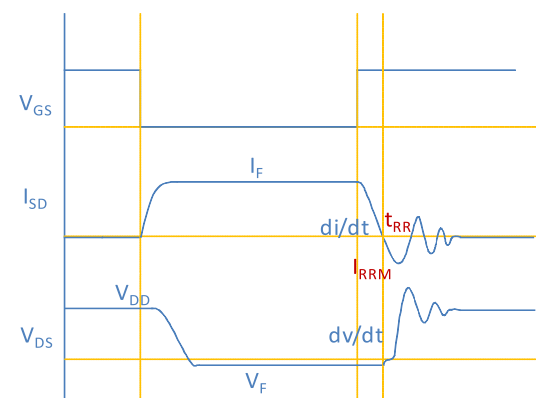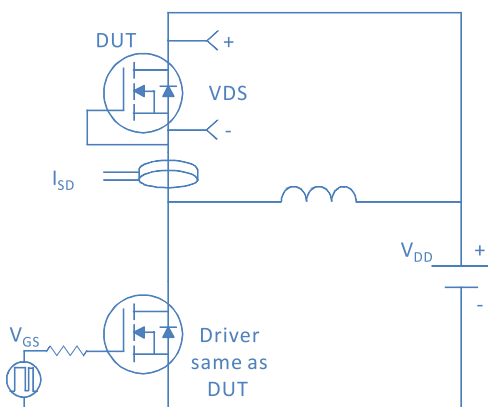
SOIC-8, 8 leads

Dimension in mm

Dimension	A	B	C	D	E	F	G	H	I	J	K
Min.	4.70	3.70	5.80	0.33		1.20	0.08	0.40	0.19	0.25	0°
Typ.					1.27						
Max.	5.10	4.10	6.20	0.51		1.62	0.28	0.83	0.26	0.50	8°